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**INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT**

Applicant: Fukuyama

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Group Art Unit: Unassigned

Date: January 7, 2003

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**U.S. PATENT DOCUMENTS**

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
20	AR	5,120,953	06/1992	Harris	250	227.20	
	BR						
	CR						
	DR						
	ER						
	FR						
	GR						
	HR						
	IR						

**FOREIGN PATENT DOCUMENTS**

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract	Translation Readily Available
						Enclosed	No
	JR						
	KR						
	LR						
	MR						
	NR						
	OR						
	PR						
	QR						
	RR						
	SR						

**OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)**

20	TR	Davidovits et al., "SCANNING LASER MICROSCOPE," Nature, Vol. 223, (August 23, 1969), 1 page			
20	UR	Juškaitis, et al., "SEMICONDUCTOR LASER CONTROL MICROSCOPY," Applied Optics, Vol. 33, No. 4 (1 February, 1994), pp. 578-584.			
20	VR	Fujita et al., "LASER FEEDBACK MICROSCOPY CONTROLLING THE LASER OSCILLATION OF SEMICONDUCTOR LASER REENTERED LIGHT," Laser Study, Vol. 24, No. 10 (October, 1996), pp1084-1090.			x
	WR				
	XR				
	YR				

Examiner

Date Considered: 9/23/03

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.